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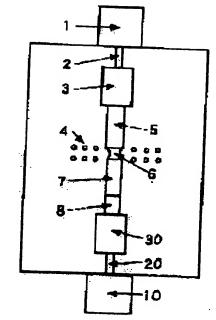
TAKENOUCHI SATOSHI

## 34) GROWTH OF ZIRCONIUM DIBORIDE SINGLE CRYSTAL

## i7)Abstract:

ROBLEM TO BE SOLVED: To enable the growth of ZrB2 ngle crystal of good quality, free from crystal defect (sub-pundary structure), by growing the crystal in a He gas mosphere and specifying the melting zone composition and e growing speed, when ZrB2 single crystal is grown through e floating zone technique.

OLUTION: A ZrB2 powder and a B powder are mixed at a ecific ratio, the powder is compressed into a bar and the r is sintered under prescribed conditions to prepare a arting sintered bar 5. The sintered bar 5 is fixed through a lder 3 to the upper shaft 2, and through the holder 30 to a lower shaft 20 thereby fixing the sintered bar 8 for ming the initial melting zone. A sintered boron (B) is serted between the sintered bar 8 and the starting sintered 5 and the sintered boron and its periphery are heated by work coil with high-frequency current to form the melting



nd 6 and the melding zone is allowed to move downward between the upper shaft 2 to the ver shaft 20 thereby growing the single crystal 7. This process is carried out in an nosphere of He gas, preferably at about 3–15 atmospheric pressure and the molecular ratio B/Zr (atomic ratio) in the melting zone composition is set to about 1.5–2.8 and the growth e is set to 3–10 cm/hour.

IAL STATUS

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